

Structural, Dielectric & Electric Properties of Manganese-Doped Barium Titanate

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Abstract

The Dielectric, Electric Properties and Microstructure of Ba $Mn_x Ti_{1-x} O_3$ (where x = 0.0, 0.01, 0.02, 0.03, 0.04) ceramics have been investigated. The ceramic samples were prepared by Solid-State Reaction Method. The SEM microstructure shows grain size decreased from 192.93 nm down to 167.05 nm. Tetragonal structure was found for samples 0.03% and 0.04% Mn-doped BaTiO₃ while others showed pseudo-cubic structure. The Dielectric Constant measurements were executed as a function of temperature. Pure and 0.03% Mn-doped ceramics showed improved dielectric constant around Curie temperature region. The temperature dependence of electrical resistivity for all samples were noted acquired that the resistivity changes with the addition of Mn⁺³ ions in the conduction process accordingly, except pure barium titanate i.e, x=0.0.

Keywords: Pervoskite, Tetragonality, Polarization, Dielectric Property.

Introduction: Barium Titanate(BT) is a ferroelectric material with perovskite structure which has been of practical importance for over 60 years due to its electrical properties [1]. It is used in multilayer capacitors as dielectric material, piezoelectric transducers, gas sensors, thermistors and so on. The crystal structure is a primitive cube, with the Ba larger cation in



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lattice[13]. The purpose of our work is to investigate the dielectric, electric properties and microstructure of manganese doped Barium Titanate BaTiO₃.

Materials and Method:

The precursor mixture was obtained by analytical grade BaCO₃(99.0%), TiO₂(99.0%) and Mn₂O₃(99.9%) all from MERCK, Germany All the raw materials were milled in a high precision planetary ball mill (FRITSCH "PULVERISETTE 6") individually for 5 hours. SEM analysis showed that milling downsized the particle of the material into nanometer range. The grounded BaCO₃, TiO₂ and Mn₂O₃ were mixed together according to the stoichiometric equation BaMn_xTi_{1-x}O₃ where x= 0, 0.01, 0.02, 0.03, 0.04. After that, each mixture was milled for 18 hours in dry medium again using aluminum ball to avoid contamination. The mixtures were pre sintered at 700°C for 3 hours in air. The ground BT was mixed with a binder (4% of Polyvinyl alcohol aqueous solution) and were pressed into disk-like pellets applying pressure 2±0.5 M Pa for 1 min. The pellets were then sintered in a programmable muffle furnace (Nabertherm) at 1150°C for 3 h in the air. The synthesized samples were characterized by SEM (Hitachi, S-3400N), XRD (EMMA, GBC Scientific equipment radiation functioned at 40KV and 40 mA, source Cu-ka (λ =1.54052°A) and Impedance Analyzer (Agilent 4294A, 40 kHz to 120MHz).





Fig. 1: XRD Patterns of BaMn_xTi_{1-x}O_{3.}

X-ray diffraction patterns of different samples doped and undoped with different composition of Mn_2O_3 content of 0.01%, 0.02%, 0.03% and 0.04% respectively. Tetragonality increases with the doping content. Pure and 0.01 and 0.02% Mn-doped BaTiO₃ shows pseudo-cubic structure, while 0.03% and 0.04% doped BaTiO₃ shows a tetragonal structure having a slightly increasing c/a ratio of 1.004648 and 1.000548 respectively.

3.2. Microstructure Analysis



Note: Accepted manuscripts are articles that have been peer-reviewed and accepted for publication by the Editorial Board. These articles have not yet been copyedited and/or formatted in the journal house style.



Fig. 2: SEM micrographs of pure and doped BaTiO_{3.}

The SEM study (figure 2) implemented on both pure and Mn-doped BT. Microstructures show agglomerated grain distribution throughout the sample. The SEM micrographs examined that the average grain size of Mn-doped BaTiO₃ ceramics are 183.2 nm, 167.05 nm, 192.93 nm, 178.52 nm, 173.46 nm as the Mn content increases from 0, 0.01, 0.02, 0.03, 0.04% respectively. It is clear that the mixture of Manganese does not effect radically on the average grain size of BTO ceramics. From the figure, it can be analyzed that BT becomes less porous and with the increase of Mn content.

3.3. Dielectric Properties

Ferroelectric materials have high dielectric constant [14]. Dielectric properties of the ceramics can be described by the temperature dependence of the dielectric constant and dielectric loss (Table 1. and figure 3(a)) in the heating process. Table 1 shows the change of dielectric constant with temperature. In the case of ferroelectric ceramics, the dielectric maxima at the temperatures which is called the Curie temperature are corresponds to the structural phase transition, i.e, a ferroelectric to a paraelectric transition [15]. The dielectric constant was calculated from the capacitance using the following equation,

$$\varepsilon = \frac{Cd}{\varepsilon_0 A}....(1)$$

where C is the capacitance (F), d the thickness (m), A is the area (m²) and $\varepsilon_0=8.85\times10^{-12}$ F m⁻¹.

Table1 shows that the transition temperature T_c was found 120°C for pure and 130°C for 0.01, 0.02 and 0.04% Mn composition and 135°C for 0.03% Mn composition. Structural disorder might be the reason for the shift of T_c [16]. The dielectric constant of the sample



shows the same characteristics. Table 1 gives a data showing how dielectric constant changes with varying manganese doping. The maximum dielectric constant was found 43800 while Ni-doped BT showed a maximum value in the dielectric constant is 81200 at the transition temperature; this is one of the highest values reached for ceramic capacitors [17]. The energy storage aptitude i.e, dielectric constant of a capacitor can be improved by using dielectric materials. Reason behind the improved dielectric constant is induced charges created due to dielectric polarization, increase charges on the plates of the capacitor. The dielectric constant ϵ of a material is

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$$\varepsilon = \varepsilon_0 + \frac{P}{E}$$

Where, ε_0 is the dielectric constant in vacuum, P is the polarization and E is the electric field intensity [18]. Below Curie temperature, polarization of a material without any applied external electric field on it is known as spontaneous polarization, i.e, random orientation of the electric dipoles. A relation lies between the spontaneous polarization and the crystal structure of a ferroelectric material. As a result of the decrement of the crystallinity of a material, ferroelectricity refrains and amorphous state created [19]. From Table 1, maximum dielectric constant with varying temperature was found for the minimum grain size. But for the rest of the samples dielectric constant increases with the increasing grain size. This is because of the change of spontaneous polarization of the material. The dielectric constant values of the BT were studied in the frequency range 55 kHz to 110MHz at room temperature is given in figure. The dielectric constant of 0.01% Mn-doped Barium Titanate is found maximum and minimum dielectric constant is found for pure BaTiO₃. According to Clausius–Mosotti relation, the dielectric constant of the material is associated to polarizability [20]. At this lower frequency range dielectric constant is found due to orientational, electronic and ionic polarization[21]. Inhomogeneous dielectric structure might be



responsible for the large value of the dielectric constant. Impurities, porosity and grain structure resembles the in homogeneities [22].

As shown in figure 3(a), it is clear that the dielectric loss decreases drastically with the increasing Mn contents. Dopants like Mg^{2+} , Ni^{2+} , Fe^{3+} , Mn^{2+} , Mn^{3+} , Co^{2+} , Co^{3+} , Al^{3+} , Cr^{3+} , Bi^{3+} can occupy the B site of the ABO₃ perovskite structure, behave as an electron acceptor and decrease the dielectric loss[23]. Maximum Dielectric losses were found 0.017, 0.013, 0.008, 0.009, and 0.008 for pure BT and 0.01, 0.02, 0.03 and 0.04% with Mn additives respectively.



Fig. 3: Variation of Dielectric Loss as a function of (a) Temperature and (b) Frequency for various Ba Mn_xTi_{1-x}O_{3.}

From figure 3(b), the tangent loss with frequency was also found increased with the Mn concentration, except for x=0.04. But for 0.04% Mn additive value, the dielectric constant was found low. However, the value of the loss factor was increased with the increasing frequency. The combined effect of space charge polarization and domain wall relaxation causes a tangent loss in ferroelectrics [21].

Value of x for sample	Temperature Dependent Dielectric	Curie Temperature(Tc)°C	Frequency Dependent Dielectric
Composition	Constant		Constant



0.00	37700	120	326.3791
0.01	43800	130	898.0966
0.02	40900	130	1680.389
0.03	38400	135	358.0475
0.04	36300	130	417.013

Table 1: Dielectric Constant and Curie temperature variation of BaMn_xTi_{1-x}O_{3.}

3.4. Electric Property

In doped BT, the temperature-dependent resistivity was found. It is a grain boundary dependent characteristics [24]. To calculate resistivity we use the following equation,

Where A is the cross-sectional area of the sample and L is the length separating the contacts.



Fig 4: Variation of resistivity as a function of (a) Temperature and (b) Frequency of BaMn_vTi_{1v}O₃

3.4.1. Temperature-dependent Resistivity

The temperature-dependent electrical resistivity of the samples was measured by using two probe techniques. This graphical expression (figure 4(a)) shows BT with 0.01% Mn doping exhibit the highest PTRC behavior whereas with 0.02% and 0.04% Mn-doping, the resistivity



curves collapse. In our previous study, we have seen that Bi-doped BT has low PTRC behavior[25] also dielectric constant and resistivity depends on the grain size[26] for Ce and Zr-doped BT. The potential barrier, positioned at the grain boundary and entrapping of the charge carriers through the polar region increases the resistivity [11].

3.4.2. Frequency dependent Resistivity

Frequency dependent electrical resistivity is shown in the figure 4(b). Graphs show that BT with 0.03% and 0.04% Mn-doping exhibit higher resistivity. So resistivity increases with the doping concentration. From figure it can also be assumed that resistivity is lower in the MHz frequency range, i.e. in this range conductivity is higher. The frequency dependent conductivity can be explained by the jump relaxation model, where the translational hopping and localized orientational hopping are accountable for electron conduction. At low frequency, the conductivity may be due to the translational hopping and at higher frequencies, the conductivity may be due to the localized orientation hopping [27].

4. Conclusion

The polycrystalline samples of Ba $Mn_x Ti_{1-x} O_3$ (x=0.0 - 0.04) were prepared by conventional solid-state reaction route. The XRD analysis exposes the presence of both pseudo-cubic and tetragonal phases. The SEM study confirms the microstructure of the samples. Maximum Curie temperature was found 135°C. The dielectric measurements have shown that our samples are responsive to the applied frequency and temperature. The samples indicated PTC behavior in resistivity. Highest resistivity was noticed for 0.01% Mn-doped BaTiO₃. The frequency dependent resistivity specifies that the conduction is due to localized orientational hopping.

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